

WNM6002

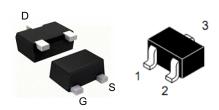
Single N-Channel, 60V, 0.30A, Power MOSFET

V _{DS} (V)	Rds(on) (Ω)			
60	1.4@ V _{GS} =10V			
60	1.7@ V _{GS} =4.5V			
ESD Rating:2000V HBM				

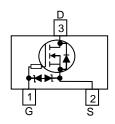
Descriptions

The WNM6002 is N-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent $R_{\rm DS(ON)}$ with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WNM6002 is Pb-free and Halogen-free.

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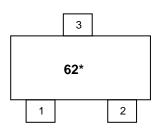
SOT-323



Features

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package SOT-323

Pin configuration (Top view)



62 = Device Code

* = Month ($A \sim Z$)

Marking

Applications

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

Order information

Device	Package	Shipping
WNM6002-3/TR	SOT-323	3000/Reel&Tape



Parameter		Symbol	10 s	Steady State	Unit	
Drain-Source Voltage		V_{DS}	60		V	
Gate-Source Voltage		V_{GS}	±20		V	
Continuous Drain Current ^{ad}	T _A =25°C	1	0.30	0.28	А	
Continuous Diain Current	T _A =70°C	l _D	0.24	0.22	Α	
Maximum Power Dissipation ad	T _A =25°C	В	0.37	0.31	W	
Maximum Fower Dissipation	Dissipation ad $T_A=70^{\circ}C$ P_D	0.23	0.20	۷V		
Continuous Drain Current bd	T _A =25°C	l _D	0.27	0.24	۸	
Continuous Drain Current	T _A =70°C		0.21	0.19	Α	
Maximum Power Dissipation bd	T _A =25°C		0.29	0.23	10/	
Maximum Power Dissipation	T _A =70°C	$ P_{D}$	0.18	0.14	W	
Pulsed Drain Current ^c		I _{DM}		1.0	Α	
Operating Junction Temperature		TJ	-55 to 150		°C	
Lead Temperature		T_L	260		°C	
Storage Temperature Range		T _{stg}	-55 to 150		°C	

Thermal resistance ratings

Parameter	Symbol	Typical	Maximum	Unit	
Junction-to-Ambient Thermal Resistance ^a	t ≤ 10 s	D	245	335	
Junction-to-Ambient Thermal Resistance	Steady State	$R_{\theta JA}$	325	395	
Lunation to Ambient Thomas Decistors of	t ≤ 10 s	D	375	430	°C/W
Junction-to-Ambient Thermal Resistance ^D	Steady State	$R_{\theta JA}$	445	535	
Junction-to-Case Thermal Resistance	Steady State	$R_{ heta JC}$	260	300	

- a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper
- b Surface mounted on FR-4 board using minimum pad size, 1oz copper
- c Pulse width<380µs
- d Maximum junction temperature $T_J=150$ °C.

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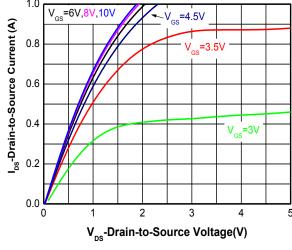
Electronics Characteristics (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	BV _{DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \text{uA}$	60			V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V, V _{GS} = 0V			1	uA	
Gate-to-source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{V}$			±5	uA	
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250uA$	0.8	1.3	2	V	
Drain-to-source On-resistance b, c	Б	$V_{GS} = 10V, I_D = 0.37A$		1.4	2.0	0	
Drain-to-source On-resistance	R _{DS(on)}	$V_{GS} = 4.5V, I_D = 0.2A$		1.7	2.6	Ω	
Forward Transconductance	g FS	V _{DS} =15V, I _D =0.25A		0.42		S	
CAPACITANCES, CHARGES	CAPACITANCES, CHARGES						
Input Capacitance	C _{ISS}	$V_{GS} = 0 V$,		23.37			
Output Capacitance	Coss	f = 1.0 MHz,		7.33		pF	
Reverse Transfer Capacitance	C _{RSS}	$V_{DS} = 25V$		5.2			
Total Gate Charge	Q _{G(TOT)}	V 10 V		1.2			
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 10 \text{ V},$ $V_{DD} = 30 \text{ V},$		0.15		nC	
Gate-to-Source Charge	Q_{GS}	$V_{DD} = 30 \text{ V},$ $I_{D} = 0.37 \text{A}$		0.21			
Gate-to-Drain Charge	Q_{GD}	- ID -0.57 A		0.12			
SWITCHING CHARACTERISTICS	SWITCHING CHARACTERISTICS						
Turn-On Delay Time	td(ON)			7.6			
Rise Time	tr	V_{DD} =30V, I_{D} =0.2A,		5.1			
Turn-Off Delay Time	td(OFF)	$V_{GEN}=10V,R_{G}=10 \Omega$		24.6		ns	
Fall Time	tf			10			
BODY DIODE CHARACTERISTICS							
Forward Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 0.3 \text{A}$		0.9	1.5	V	

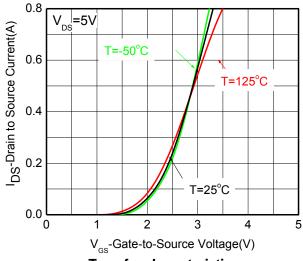
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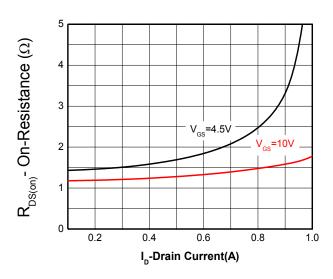
Typical Characteristics (Ta=25°C, unless otherwise noted)



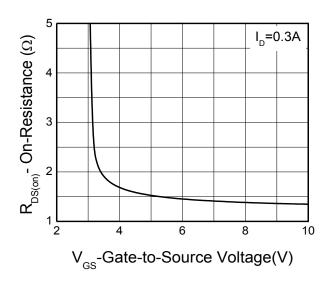
Output characteristics



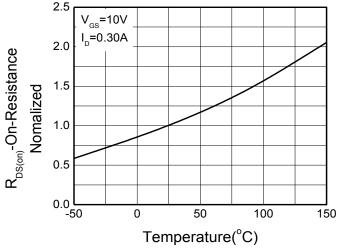
Transfer characteristics



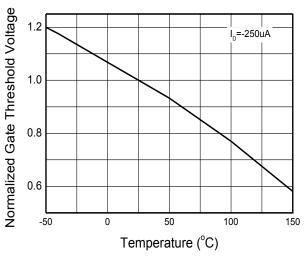
On-Resistance vs. Drain current



On-Resistance vs. Gate-to-Source voltage

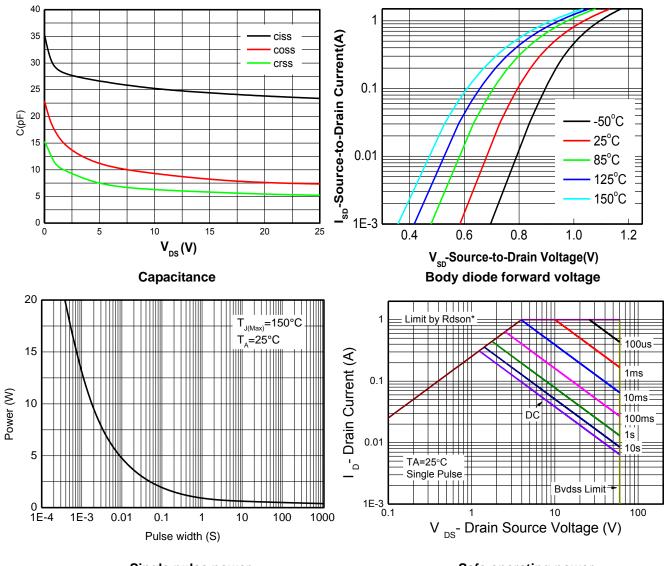


On-Resistance vs. Junction temperature



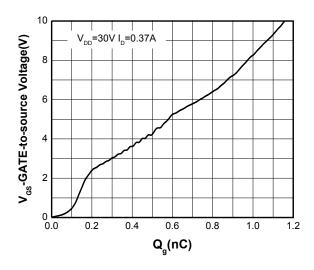
Threshold voltage vs. Temperature





Single pulse power

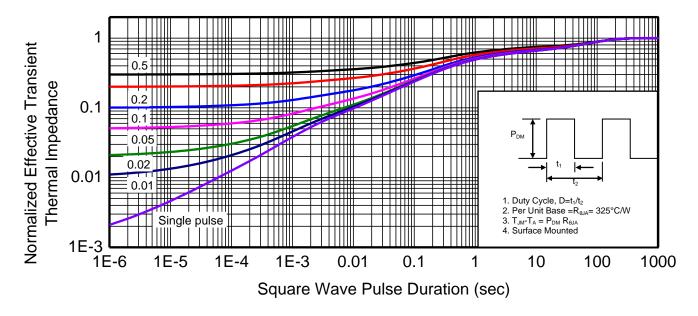
Safe operating power



Gate Charge Characteristics

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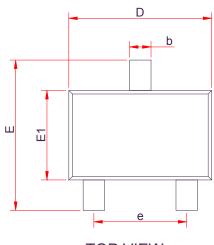
Transient thermal response (Junction-to-Ambient)

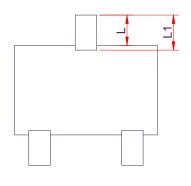
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Package outline dimensions

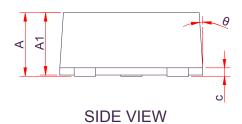
SOT-323





TOP VIEW





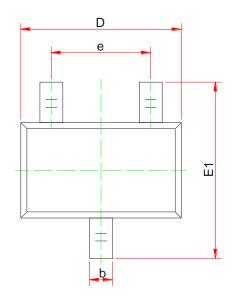
Comple of	Dimensions in Millimeters				
Symbol	Min.	Тур.	Max.		
A	0.80	0.90	1.00		
A1		0.89 Ref			
b	0.28	0.30	0.35		
е	1.20	1.30	1.40		
С	0.11	0.13	0.18		
D	1.80	2.00	2.20		
E	2.00	2.00 2.10 2.3			
E1	1.15	1.15 1.25			
L1	0.49 Ref				
L	0.42		0.43		
θ	5° Ref				

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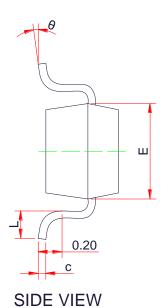


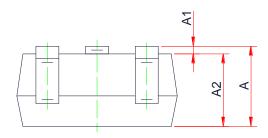
Package outline dimensions

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TOP VIEW





SIDE VIEW

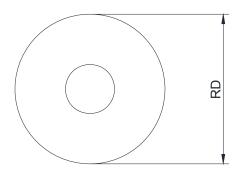
Symbol	Dimensions in Millimeters				
Зушьог	Min.	Тур.	Max.		
А	0.80	0.95	1.10		
A1	0.00	-	0.10		
A2	0.80	0.90	1.00		
b	0.20	0.30	0.40		
С	0.05	0.10	0.15		
D	1.90	2.05	2.20		
Е	1.15	1.25	1.25		
E1	2.00	2.20	2.45		
е	1.20	1.30	1.40		
L	0.20	-	-		
θ		6° Ref			

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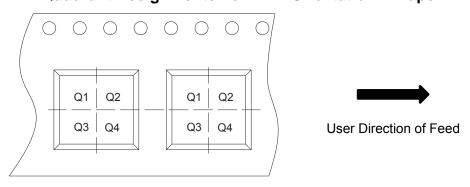
TAPE AND REEL INFORMATION

Reel Dimensions



Tape Dimensions

Quadrant Assignments For PIN1 Orientation In Tape

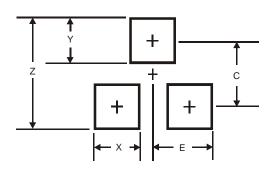


RD	Reel Dimension	☑ 7inch	☐ 13inch		
W	Overall width of the carrier tape	▼ 8mm	☐ 12mm	☐ 16mm	
P1	Pitch between successive cavity centers	☐ 2mm	✓ 4mm	☐ 8mm	
Pin1	Pin1 Quadrant	□ Q1	□ Q2	▼ Q3	□ Q4



Recommend PCB Layout

Recommend PCB Layout (Unit: mm)



Dimensions	SOT323
Z	2.8
Х	0.7
Y	0.9
С	1.9
E	1.0

Notes:

This recommended land pattern is for reference purposes only. Please consult your manufacturing group to ensure your PCB design guidelines are met.

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